

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/500,684		PIENA, MARTINUS JOHANNES	
				Examiner		Art Unit	
				Hai L. Nguyen		2816	

ORIGINAL				CROSS REFERENCE(S)											
CLASS		SUBCLASS		CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)									
313		491		313		631									
INTERNATIONAL CLASSIFICATION															
H	0	1	J	63/04											
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Hai L. Nguyen (Assistant Examiner)				5/24/2006 (Date)		TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner)				Total Claims Allowed: 11					
Anh M. Smith (Legal Instruments Examiner)				5/31/06 (Date)		J. Miller (Date)				O.G. Print Claim(s) 1		O.G. Print Fig. 1 & 2			

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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